

Notice of References Cited	Application/Control No. 10/089,674	Applicant(s)/Patent Under Reexam Lee	
	Examiner R.S. Travers J.D., Ph.D.	Art Unit 1617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
	A	4,914,131	4/1990	Haines et al	514	626
	B					
	C					
	D					
	E					
	F					
	G					
	H					
	I					
	J					
	K					
	L					
	M					

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Country	Name	Classification ²	
x	N	0 316 117	5/1989	EPO	Shenfeld	CO7F	9/10
x	O	1129113A	1/1995	China	N/A	A61K	35/78
x	P	0 572 922	5/1993	EPO	Weischer et al	A61K	31/385
x	Q	WO 91/03246	3/1991	WIPO	Pauza et al	A61K	31/59
	R						
	S						
	T						

NON-PATENT DOCUMENTS

*		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
	U	Asanaka et al, 112CA:232458, 1990
	V	
	W	
	X	

* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a). ¹ Dates in MM-YYYY format are publication dates. ² Classifications may be U.S. or foreign.